

Replaces DS5906-2

# DIM800XSM33-F000

## Single Switch IGBT Module

DS5906-3 October 2015 (LN33013)

## FEATURES

- 10µs Short Circuit Withstand
- High Thermal Cycling Capability
- Soft Punch Through Silicon
- Isolated AISiC Base with AIN Substrates
- Lead Free Construction
- 10.2kV Isolation Package

## **APPLICATIONS**

- High Reliability Inverters
- Motor Controllers
- Traction Drives
- Choppers

The Powerline range of high power modules includes half bridge, chopper, dual, single and bi-directional switch configurations covering voltages from 1200V to 6500V and currents up to 2400A.

The DIM800XSM33-F000 is a single switch 3300V, soft punch through n-channel enhancement mode, insulated gate bipolar transistor (IGBT) module. The IGBT has a wide reverse bias safe operating area (RBSOA) plus 10µs short circuit withstand. This device is optimised for traction drives and other applications requiring high thermal cycling capability.

The module incorporates an electrically isolated base plate and low inductance construction enabling circuit designers to optimise circuit layouts and utilise grounded heat sinks for safety.

#### **ORDERING INFORMATION**

Order As:

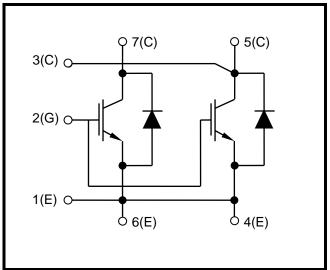
## DIM800XSM33-F000

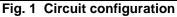
Note: When ordering, please use the complete part number

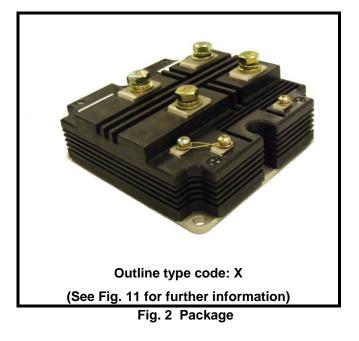
#### **KEY PARAMETERS**

V <sub>CES</sub>		3300V
V <sub>CE(sat)</sub>	* (typ)	2.8V
l <sub>c</sub>	(max)	800A
I <sub>С(РК)</sub>	(max)	1600A

\* Measured at the auxiliary terminals







Caution: This device is sensitive to electrostatic discharge. Users should follow ESD handling procedures

## **ABSOLUTE MAXIMUM RATINGS**

Stresses above those listed under 'Absolute Maximum Ratings' may cause permanent damage to the device. In extreme conditions, as with all semiconductors, this may include potentially hazardous rupture of the package. Appropriate safety precautions should always be followed. Exposure to Absolute Maximum Ratings may affect device reliability.

#### T<sub>case</sub> = 25°C unless stated otherwise

Symbol	Parameter	Test Conditions	Max.	Units
V <sub>CES</sub>	Collector-emitter voltage	$V_{GE} = 0V$	3300	V
$V_{\text{GES}}$	Gate-emitter voltage		±20	V
Ι <sub>C</sub>	Continuous collector current	T <sub>case</sub> = 90°C	800	А
I <sub>C(PK)</sub>	Peak collector current	1ms, T <sub>case</sub> = 115°C	1600	А
P <sub>max</sub>	Max. transistor power dissipation	$T_{case} = 25^{\circ}C, T_{j} = 150^{\circ}C$	10400	W
l <sup>2</sup> t	Diode l <sup>2</sup> t value	$V_{R} = 0, t_{p} = 10ms, T_{j} = 125^{\circ}C$	320	kA <sup>2</sup> s
V <sub>isol</sub>	Isolation voltage – per module	Commoned terminals to base plate. AC RMS, 1 min, 50Hz	10.2	kV
Q <sub>PD</sub>	Partial discharge – per module	IEC1287, $V_1 = 6900V$ , $V_2 = 5100V$ , 50Hz RMS	10	рС

#### THERMAL AND MECHANICAL RATINGS

Internal insulation material:	AIN
Baseplate material:	AISiC
Creepage distance:	56mm
Clearance:	26mm
CTI (Comparative Tracking Index):	>600

Symbol	Parameter	Test Conditions	Min	Тур.	Мах	Units
R <sub>th(j-c)</sub>	Thermal resistance – transistor	Continuous dissipation – junction to case	-	-	12	°C/kW
R <sub>th(j-c)</sub>	Thermal resistance – diode	Continuous dissipation – junction to case	-	-	24	°C/kW
R <sub>th(c-h)</sub>	Thermal resistance – case to heatsink	ce – case to heatsink Mounting torque 5Nm (with mounting grease)		-	8	°C/kW
-		Transistor	-	-	150	°C
Tj	Junction temperature	Diode	-	-	125	°C
T <sub>stg</sub>	Storage temperature range	-	-40	-	125	°C
		Mounting – M6	-	-	5	Nm
	Screw torque	Electrical connections – M4	-	-	2	Nm
		Electrical connections – M8	-	-	10	Nm

## **ELECTRICAL CHARACTERISTICS**

#### T<sub>case</sub> = 25°C unless stated otherwise.

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
		$V_{GE} = 0V, V_{CE} = V_{CES}$			4	mA
I <sub>CES</sub>	Collector cut-off current	$V_{GE} = 0V, V_{CE} = V_{CES}, T_{case} = 125^{\circ}C$			60	mA
I <sub>GES</sub>	Gate leakage current	$V_{GE} = \pm 20V, V_{CE} = 0V$			1	μA
V <sub>GE(TH)</sub>	Gate threshold voltage	$I_{C} = 80 \text{mA}, V_{GE} = V_{CE}$	5.5	6.5	7.0	V
v †	Collector-emitter saturation	V <sub>GE</sub> = 15V, I <sub>C</sub> = 800A		2.8		V
V <sub>CE(sat)</sub> †	voltage	V <sub>GE</sub> = 15V, I <sub>C</sub> = 800A, T <sub>j</sub> = 125°C		3.6		V
١ <sub>F</sub>	Diode forward current	DC		800		А
I <sub>FM</sub>	Diode maximum forward current	t <sub>p</sub> = 1ms		1600		А
v t		I <sub>F</sub> = 800A		2.9		V
$V_{F}^{\dagger}$	Diode forward voltage	I <sub>F</sub> = 800A, T <sub>j</sub> = 125°C		3.0		V
C <sub>ies</sub>	Input capacitance	V <sub>CE</sub> = 25V, V <sub>GE</sub> = 0V, f = 1MHz		144		nF
Qg	Gate charge	±15V		20		μC
C <sub>res</sub>	Reverse transfer capacitance	V <sub>CE</sub> = 25V, V <sub>GE</sub> = 0V, f = 1MHz		2.2		nF
L <sub>M</sub>	Module inductance			15		nH
R <sub>INT</sub>	Internal resistance			135		μΩ
SC <sub>Data</sub>	Short circuit current, I <sub>SC</sub>	$\begin{split} T_{j} &= 125^{\circ}C, \ V_{CC} &= 2500V \\ t_{p} &\leq 10\mu s, \ V_{GE} &\leq 15V \\ V_{CE \ (max)} &= V_{CES} - L^{*} \ x \ dl/dt \\ IEC \ 60747-9 \end{split}$		3700		A

#### Note:

 $^{\dagger}$  Measured at the auxiliary terminals  $^{\star}$  L is the circuit inductance +  $L_{M}$ 

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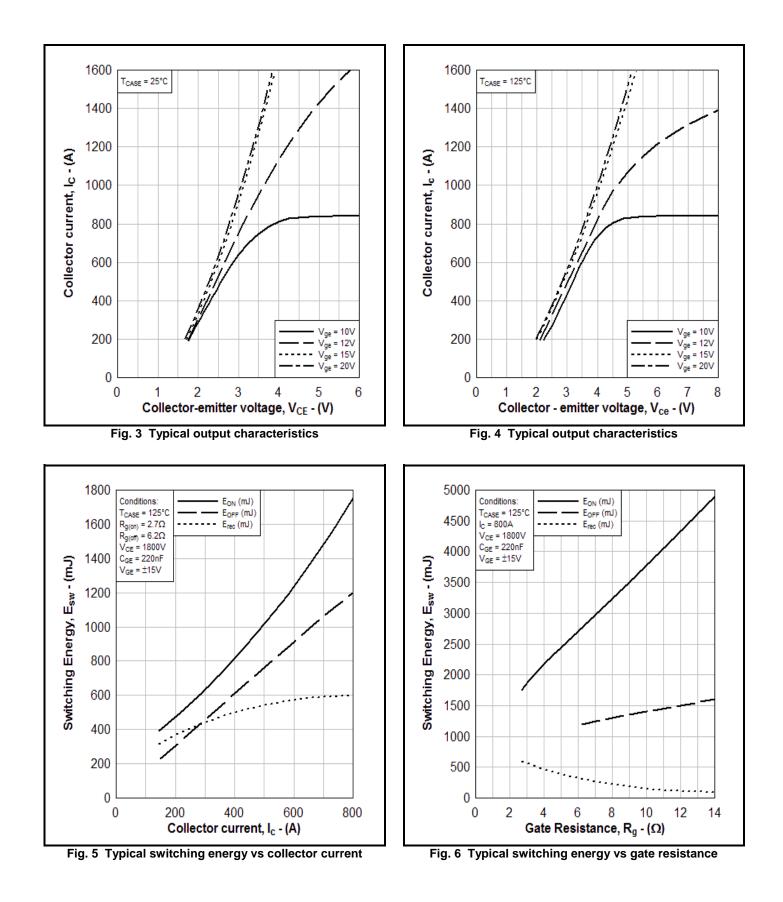
## **ELECTRICAL CHARACTERISTICS**

T<sub>case</sub> = 25°C unless stated otherwise

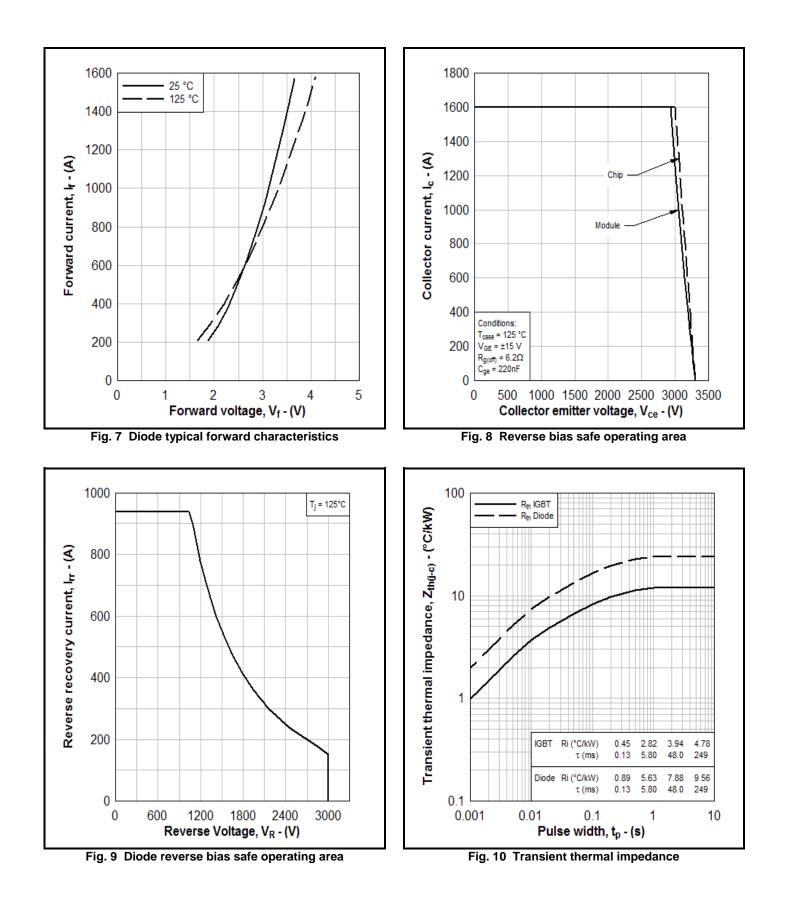
Symbol	Parameter	Test Conditions		Min	Тур.	Max	Units
t <sub>d(off)</sub>	Turn-off delay time		$I_{C} = 800A$ $V_{GE} = \pm 15V$ $V_{CE} = 1800V$ $R_{G(OFF)} = 6.2\Omega$		3.0		μs
t <sub>f</sub>	Fall time	-			270		ns
E <sub>OFF</sub>	Turn-off energy loss				1050		mJ
t <sub>d(on)</sub>	Turn-on delay time	$V_{CE} = 1800V$ $C_{qe} = 220nF$			1300		ns
t <sub>r</sub>	Rise time	L <sub>s</sub> ~ 100nH			275		ns
E <sub>ON</sub>	Turn-on energy loss		$\begin{aligned} R_{G(ON)} &= 2.7\Omega \\ R_{G(OFF)} &= 6.2\Omega \end{aligned}$		1250		mJ
Q <sub>rr</sub>	Diode reverse recovery charge	I <sub>F</sub> = 800A			320		μC
I <sub>rr</sub>	Diode reverse recovery current	V <sub>CE</sub> =			670		А
E <sub>rec</sub>	Diode reverse recovery energy	dI <sub>F</sub> /dt = 4000A/µs			300		mJ

#### T<sub>case</sub> = 125°C unless stated otherwise

Symbol	Parameter	Test Conditions		Min	Тур.	Max	Units
t <sub>d(off)</sub>	Turn-off delay time		$\begin{array}{l} R_{G(ON)} = 3.9\Omega \\ R_{G(OFF)} = 6.2\Omega \end{array}$		3.1		μs
t <sub>f</sub>	Fall time	I <sub>C</sub> = 800A V <sub>GE</sub> = ±15V			280		ns
E <sub>OFF</sub>	Turn-off energy loss				1200		mJ
t <sub>d(on)</sub>	Turn-on delay time	V <sub>CE</sub> = 1800V C <sub>ge</sub> = 220nF			1200		ns
t <sub>r</sub>	Rise time	L <sub>s</sub> ~ 100nH			315		ns
E <sub>ON</sub>	Turn-on energy loss		$\begin{aligned} R_{G(ON)} &= 2.7\Omega \\ R_{G(OFF)} &= 6.2\Omega \end{aligned}$		1750		mJ
Q <sub>rr</sub>	Diode reverse recovery charge	I <sub>F</sub> = 800A			600		μC
I <sub>rr</sub>	Diode reverse recovery current	V <sub>CE</sub> =			800		А
E <sub>rec</sub>	Diode reverse recovery energy	$dI_F/dt = 4$	000A/µs		600		mJ



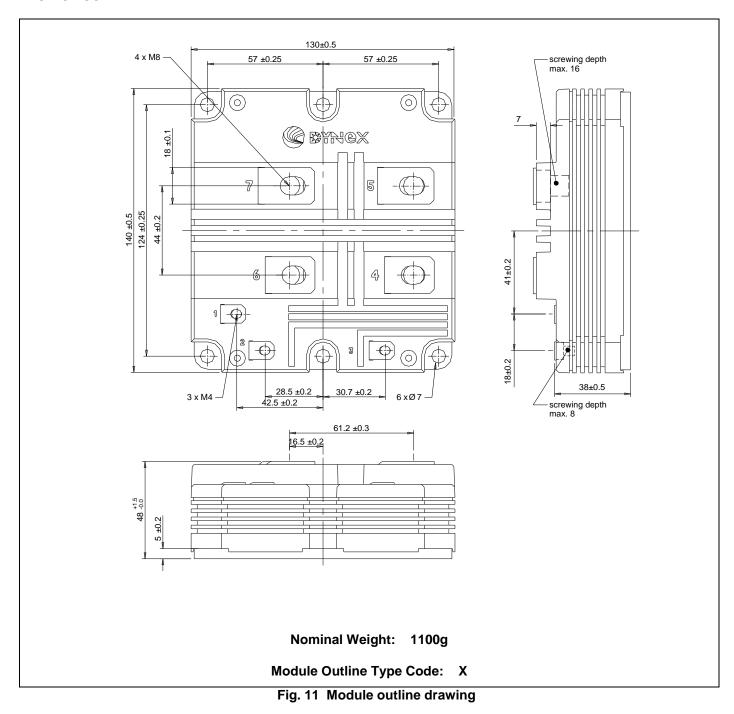
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#### PACKAGE DETAILS

For further package information, please visit our website or contact Customer Services. All dimensions in mm, unless stated otherwise. **DO NOT SCALE.** 



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